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INTERNATIONAL STANDARD



**Metallic-communication cables and other passive components test methods –
Part 4-15: Electromagnetic compatibility (EMC) – Test method for measuring
transfer impedance and screening attenuation – or coupling attenuation with
triaxial cell**

INTERNATIONAL
ELECTROTECHNICAL
COMMISSION

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

METALLIC ~~COMMUNICATION~~ CABLES AND OTHER PASSIVE COMPONENTS TEST METHODS –

Part 4-15: Electromagnetic compatibility (EMC) – Test method for measuring transfer impedance and screening attenuation – or coupling attenuation with triaxial cell

FOREWORD

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This redline version of the official IEC Standard allows the user to identify the changes made to the previous edition IEC 62153-4-15:2015. A vertical bar appears in the margin wherever a change has been made. Additions are in green text, deletions are in strikethrough red text.

International Standard IEC 62153-4-15 has been prepared by IEC technical committee 46: Cables, wires, waveguides, R.F. connectors, R.F. and microwave passive components and accessories.

This second edition cancels and replaces the first edition published in 2015. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) measurement of coupling attenuation of balanced connectors, assemblies and components with balun and balunless added;
- b) application of a test adapter was added;
- c) application of a moveable shorting plane;
- d) application of the triaxial "absorber" cell;
- e) correction of test results in the case that the receiver input impedance R is higher than the characteristic impedance of the outer circuit Z_2 .

The text of this International Standard is based on the following documents:

FDIS	Report on voting
46/814/FDIS	46/822/RVD

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are described in greater detail at www.iec.ch/standardsdev/publications.

A list of all the parts in the IEC 62153-4 series, published under the general title *Metallic communication cable test methods – Electromagnetic compatibility (EMC)*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under webstore.iec.ch in the data related to the specific document. At this date, the document will be

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METALLIC ~~COMMUNICATION~~ CABLES AND OTHER PASSIVE COMPONENTS TEST METHODS –

Part 4-15: Electromagnetic compatibility (EMC) – Test method for measuring transfer impedance and screening attenuation – or coupling attenuation with triaxial cell

1 Scope

This part of IEC 62153 specifies the procedures for measuring with triaxial cell the transfer impedance, screening attenuation or the coupling attenuation of connectors, cable assemblies and components, for example accessories for analogue and digital transmission systems, and equipment for communication networks and cabling ~~(in accordance with the scope of IEC technical committee 46).~~

Measurements can be achieved by applying the device under test directly to the triaxial cell or with the tube-in-tube method in accordance with IEC 62153-4-7.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 61196-1, *Coaxial communication cables – Part 1: Generic specification – General, definitions and requirements*

IEC TS 62153-4-1:~~2013~~2014, *Metallic communication cable test methods – Part 4-1: Electromagnetic Compatibility (EMC) – Introduction to electromagnetic screening measurements*

IEC 62153-4-3, *Metallic communication cable test methods – Part 4-3: Electromagnetic compatibility (EMC) – Surface transfer impedance – Triaxial method*

IEC 62153-4-4:~~2015~~, *Metallic communication cable test methods – Part 4-4: Electromagnetic compatibility (EMC) – ~~Shielded screening attenuation~~, Test method for measuring of the screening attenuation a_s up to and above 3 GHz, triaxial method*

IEC 62153-4-7, *Metallic communication cable test methods – Part 4-7: Electromagnetic compatibility (EMC) – Test method for measuring the transfer impedance Z_T and the screening attenuation a_s or coupling attenuation a_c of connectors and assemblies up to and above 3 GHz – Triaxial Tube in tube method*

IEC 62153-4-8, *Metallic ~~communication~~ cables and other passive components – Test methods – Part 4-8: Electromagnetic compatibility (EMC) – Capacitive coupling admittance*

IEC 62153-4-9:~~2009~~2018, *Metallic communication cable test methods – Part 4-9: Electromagnetic compatibility (EMC) – Coupling attenuation of screened balanced cables, triaxial method*

IEC 62153-4-10, *Metallic communication cable test methods – Part 4-10: Electromagnetic compatibility (EMC) – ~~Shielded screening attenuation test method for measuring the screening effectiveness~~ Transfer impedance and screening attenuation of feed-throughs and electromagnetic gaskets – Double coaxial test method*

IEC ~~IS~~ 62153-4-16, *Metallic communication cable test methods – Part 4-16: Electromagnetic compatibility (EMC) – Extension of the frequency range to higher frequencies for transfer impedance and to lower frequencies for screening attenuation measurements using the triaxial set-up*

INTERNATIONAL STANDARD

NORME INTERNATIONALE



**Metallic cables and other passive components test methods –
Part 4-15: Electromagnetic compatibility (EMC) – Test method for measuring
transfer impedance and screening attenuation – or coupling attenuation with
triaxial cell**

**Méthodes d'essais des câbles métalliques et autres composants passifs –
Partie 4-15: Compatibilité électromagnétique (CEM) – Méthode d'essai pour
le mesurage de l'impédance de transfert et de l'affaiblissement d'écran –
ou de l'affaiblissement de couplage avec cellule triaxiale**

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

**METALLIC CABLES AND OTHER PASSIVE
COMPONENTS TEST METHODS –****Part 4-15: Electromagnetic compatibility (EMC) – Test method for
measuring transfer impedance and screening attenuation –
or coupling attenuation with triaxial cell**

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METALLIC CABLES AND OTHER PASSIVE COMPONENTS TEST METHODS –

Part 4-15: Electromagnetic compatibility (EMC) – Test method for measuring transfer impedance and screening attenuation – or coupling attenuation with triaxial cell

1 Scope

This part of IEC 62153 specifies the procedures for measuring with triaxial cell the transfer impedance, screening attenuation or the coupling attenuation of connectors, cable assemblies and components, for example accessories for analogue and digital transmission systems, and equipment for communication networks and cabling.

Measurements can be achieved by applying the device under test directly to the triaxial cell or with the tube-in-tube method in accordance with IEC 62153-4-7.

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IEC TS 62153-4-1:2014, *Metallic communication cable test methods – Part 4-1: Electromagnetic Compatibility (EMC) – Introduction to electromagnetic screening measurements*

IEC 62153-4-3, *Metallic communication cable test methods – Part 4-3: Electromagnetic compatibility (EMC) – Surface transfer impedance – Triaxial method*

IEC 62153-4-4:2015, *Metallic communication cable test methods – Part 4-4: Electromagnetic compatibility (EMC) – Test method for measuring of the screening attenuation a_s up to and above 3 GHz, triaxial method*

IEC 62153-4-7, *Metallic communication cable test methods – Part 4-7: Electromagnetic compatibility (EMC) – Test method for measuring the transfer impedance Z_T and the screening attenuation a_s or coupling attenuation a_c of connectors and assemblies up to and above 3 GHz – Triaxial Tube in tube method*

IEC 62153-4-8, *Metallic cables and other passive components – Test methods – Part 4-8: Electromagnetic compatibility (EMC) – Capacitive coupling admittance*

IEC 62153-4-9:2018, *Metallic communication cable test methods – Part 4-9: Electromagnetic compatibility (EMC) – Coupling attenuation of screened balanced cables, triaxial method*

IEC 62153-4-10, *Metallic communication cable test methods – Part 4-10: Electromagnetic compatibility (EMC) – Transfer impedance and screening attenuation of feed-throughs and electromagnetic gaskets – Double coaxial test method*

IEC 62153-4-16, *Metallic communication cable test methods – Part 4-16: Electromagnetic compatibility (EMC) – Extension of the frequency range to higher frequencies for transfer impedance and to lower frequencies for screening attenuation measurements using the triaxial set-up*

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COMMISSION ÉLECTROTECHNIQUE INTERNATIONALE

**MÉTHODES D'ESSAIS DES CÂBLES MÉTALLIQUES
ET AUTRES COMPOSANTS PASSIFS –****Partie 4-15: Compatibilité électromagnétique (CEM) – Méthode d'essai
pour le mesurage de l'impédance de transfert et de l'affaiblissement
d'écran – ou de l'affaiblissement de couplage avec cellule triaxiale**

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Cette deuxième édition annule et remplace la première édition parue en 2015. Cette édition constitue une révision technique.

Cette édition inclut les modifications techniques majeures suivantes par rapport à l'édition précédente:

- a) le mesurage de l'affaiblissement de couplage des connecteurs, cordons et composants symétriques avec ou sans symétriseur a été ajouté;

- b) l'application d'un adaptateur d'essai a été ajoutée;
- c) application d'un plan de court-circuit amovible;
- d) application de la cellule "absorbeuse" triaxiale;
- e) correction des résultats d'essai dans le cas où l'impédance d'entrée du récepteur R est supérieure à l'impédance caractéristique du circuit externe Z_2 .

Le texte de cette Norme internationale est issu des documents suivants:

FDIS	Rapport de vote
46/814/FDIS	46/822/RVD

Le rapport de vote indiqué dans le tableau ci-dessus donne toute information sur le vote ayant abouti à son approbation.

La langue employée pour l'élaboration de cette Norme internationale est l'anglais.

Le présent document a été rédigé selon les Directives ISO/IEC, Partie 2, il a été développé selon les Directives ISO/IEC, Partie 1 et les Directives ISO/IEC, Supplément IEC, disponibles sous www.iec.ch/members_experts/refdocs. Les principaux types de documents développés par l'IEC sont décrits plus en détail sous www.iec.ch/standardsdev/publications.

Une liste de toutes les parties de la série IEC 62153-4, publiées sous le titre général *Méthodes d'essais des câbles métalliques de communication – Compatibilité électromagnétique (CEM)*, peut être consultée sur le site web de l'IEC.

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MÉTHODES D'ESSAIS DES CÂBLES MÉTALLIQUES ET AUTRES COMPOSANTS PASSIFS –

Partie 4-15: Compatibilité électromagnétique (CEM) – Méthode d'essai pour le mesurage de l'impédance de transfert et de l'affaiblissement d'écran – ou de l'affaiblissement de couplage avec cellule triaxiale

1 Domaine d'application

La présente partie de l'IEC 62153 spécifie les procédures de mesure de l'impédance de transfert, de l'affaiblissement d'écran ou de couplage des connecteurs, des cordons et des composants, par exemple les accessoires pour les systèmes de transmission numérique et analogique, et les équipements de réseaux de communication et de câblage, avec une cellule triaxiale.

Les mesurages peuvent être réalisés en appliquant le dispositif en essai directement sur la cellule triaxiale ou avec la méthode du tube concentrique conformément à l'IEC 62153-4-7.

2 Références normatives

Les documents suivants sont cités dans le texte de sorte qu'ils constituent, pour tout ou partie de leur contenu, des exigences du présent document. Pour les références datées, seule l'édition citée s'applique. Pour les références non datées, la dernière édition du document de référence s'applique (y compris les éventuels amendements).

IEC 61196-1, *Câbles coaxiaux de communication – Partie 1: Spécification générique – Généralités, définitions et exigences*

IEC TS 62153-4-1:2014, *Metallic communication cable test methods – Part 4-1: Electromagnetic Compatibility (EMC) – Introduction to electromagnetic screening measurements* (disponible en anglais seulement)

IEC 62153-4-3, *Metallic communication cable test methods – Part 4-3: Electromagnetic compatibility (EMC) – Surface transfer impedance – Triaxial method* (disponible en anglais seulement)

IEC 62153-4-4:2015, *Metallic communication cable test methods – Part 4-4: Electromagnetic compatibility (EMC) – Test method for measuring of the screening attenuation as up to and above 3 GHz, triaxial method* (disponible en anglais seulement)

IEC 62153-4-7, *Méthodes d'essai des câbles métalliques de communication – Partie 4-7: Compatibilité électromagnétique (CEM) – Méthode d'essai pour mesurer l'impédance de transfert Z_T et l'affaiblissement d'écrantage a_S ou l'affaiblissement de couplage a_C des connecteurs et des cordons jusqu'à 3 GHz et au-dessus – Méthode triaxiale en tubes concentriques*

IEC 62153-4-8, *Câbles métalliques et autres composants passifs - Méthodes d'essai – Partie 4-8: Compatibilité électromagnétique (CEM) – Admittance de couplage capacitif*

IEC 62153-4-9:2018, *Méthodes d'essais des câbles métalliques de communication – Partie 4-9: Compatibilité électromagnétique (CEM) – Affaiblissement de couplage des câbles symétriques écrantés, méthode triaxiale*

IEC 62153-4-10, *Méthodes d'essai des câbles métalliques de communication – Partie 4-10: Compatibilité électromagnétique (CEM) – Impédance de transfert et affaiblissement d'écran des traversées et des joints d'étanchéité électromagnétiques – Méthode d'essai coaxiale double*

IEC 62153-4-16, *Metallic communication cable test methods – Part 4-16: Electromagnetic compatibility (EMC) – Extension of the frequency range to higher frequencies for transfer impedance and to lower frequencies for screening attenuation measurements using the triaxial set-up* (disponible en anglais seulement)